

LIS331DL

MEMS motion sensor

3-axis - ±2g/±8g smart digital output "nano" accelerometer

Preliminary Data

Features

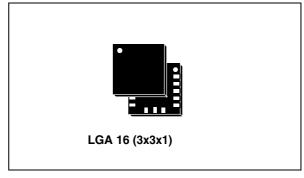
- 2.16V to 3.6V supply voltage
- 1.8V compatible IOs
- <1mW power consumption</p>
- ±2g / ±8g dynamically selectable full-scale
- I²C/SPI digital output interface
- Programmable interrupt generator
- Embedded click and double click recognition
- Embedded free-fall and motion detection
- Embedded high pass filter
- Embedded self test
- 10000g high shock survivability
- ECOPACK® RoHS and "Green" compliant (see *Section 8*)

Applications

- Free-Fall detection
- Motion activated functions
- Gaming and Virtual Reality input devices
- Vibration monitoring and compensation

Description

The LIS331DL is the smallest consumer low-power three axes linear accelerometer with digital output and smart embedded features. It includes a sensing element and an IC interface able to provide the measured acceleration to the external world through I²C/SPI serial interface.



The sensing element, capable of detecting the acceleration, is manufactured using a dedicated process developed by ST to produce inertial sensors and actuators in silicon.

The IC interface is manufactured using a CMOS process that allows to design a dedicated circuit which is trimmed to better match the sensing element characteristics.

The LIS331DL has dynamically user selectable full scales of ±2g/±8g and it is capable of measuring accelerations with an output data rate of 100Hz or 400Hz.

A self-test capability allows the user to check the functioning of the sensor in the final application.

The device may be configured to generate inertial wake-up/free-fall interrupt signals when a programmable acceleration threshold is crossed at least in one of the three axes. Thresholds and timing of interrupt generators are programmable by the end user on the fly.

The LIS331DL is available in plastic Land Grid Array package (LGA) and it is guaranteed to operate over an extended temperature range from -40°C to +85°C.

Figure 1. Device summary

Order code Temp range, ° C		Package	Packing
LIS331DL	-40 to +85	LGA	Tray
LIS331DLTR	-40 to +85	LGA	Tape and reel

Contents LIS331DL

Contents

1	Bloc	ck diagram & pin description
	1.1	Block diagram
	1.2	Pin description
2	Mec	hanical and electrical specifications9
	2.1	Mechanical characteristics
	2.2	Electrical characteristics
	2.3	Communication interface characteristics
		2.3.1 SPI interface
		2.3.2 I2C interface
	2.4	Absolute maximum ratings
	2.5	Terminology 14
		2.5.1 Sensitivity
		2.5.2 Zero-g level
		2.5.3 Self test
		2.5.4 Click and double click recognition
3	Fund	ctionality15
	3.1	Sensing element
	3.2	IC interface
	3.3	Factory calibration
4	Арр	lication hints
	4.1	Soldering information
5	Digi	tal interfaces
	5.1	I2C serial interface
		5.1.1 I2C operation
	5.2	SPI bus interface
		5.2.1 SPI read
		5.2.2 SPI write
		5.2.3 SPI read in 3-wires mode

LIS331DL Contents

6	Regi	ster mapping
7	Regis	ster description25
	7.1	WHO_AM_I (0Fh)
	7.2	CTRL_REG1 (20h)
	7.3	CTRL_REG2 (21h)
	7.4	CTRL_REG3 [interrupt CTRL register] (22h)
	7.5	HP_FILTER_RESET (23h)
	7.6	STATUS_REG (27h)
	7.7	OUT_X (29h)
	7.8	OUT_Y (2Bh)
	7.9	OUT_Z (2Dh)
	7.10	FF_WU_CFG_1 (30h)
	7.11	FF_WU_SRC_1 (31h) 30
	7.12	FF_WU_THS_1 (32h) 30
	7.13	FF_WU_DURATION_1 (33h) 31
	7.14	FF_WU_CFG_2 (34h)
	7.15	FF_WU_SRC_2 (35h) 32
	7.16	FF_WU_THS_2 (36h)
	7.17	FF_WU_DURATION_2 (37h)
	7.18	CLICK_CFG (38h) 33
	7.19	CLICK_SRC (39h) 34
	7.20	CLICK_THSY_X (3Bh)
	7.21	CLICK_THSZ (3Ch)
	7.22	CLICK_TimeLimit (3Dh)
	7.23	CLICK_Latency (3Eh)
	7.24	CLICK_Window (3Fh)
8	Pack	age information
9	Revis	sion history

List of figures LIS331DL

List of figures

Figure 1.	Device summary	. 1
Figure 2.	Block diagram	. 4
Figure 3.	Pin connection	. 4
Figure 4.	SPI slave timing diagram (2)	. 8
Figure 5.	I2C slave timing diagram (4)	. 9
Figure 6.	LIS331DL electrical connection	13
Figure 7.	Read & write protocol	16
Figure 8.	SPI read protocol	17
Figure 9.	Multiple bytes SPI read protocol (2 bytes example)	18
Figure 10.		
Figure 11.	Multiple bytes SPI write protocol (2 bytes example)	18
•	SPI read protocol in 3-wires mode	
	LGA 16: Machanical Data & Packago Dimonejone	

LIS331DL List of tables

List of tables

Pin description	. 8
Mechanical characteristics	. 9
Electrical characteristics	10
SPI slave timing values	11
I2C Slave timing values	12
Absolute maximum ratings	13
Serial interface pin description	17
Serial interface pin description	17
Register address map	23
WHO_AM_I register	
CTRL_REG1 register	25
	Mechanical characteristics Electrical characteristics SPI slave timing values. I2C Slave timing values Absolute maximum ratings Serial interface pin description Serial interface pin description Register address map.



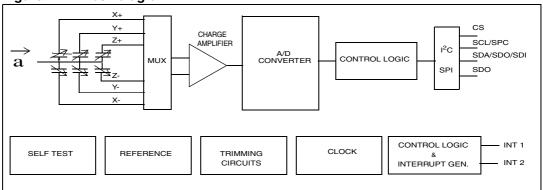
List of tables	LIS331DI

Table 49.	CLICK_TimeLimit register	35
Table 50.	CLICK_Latency	35
Table 51.	CLICK_Window register	35
Table 52.	Document revision history	37

1 Block diagram & pin description

1.1 Block diagram

Figure 2. Block diagram



1.2 Pin description

Figure 3. Pin connection

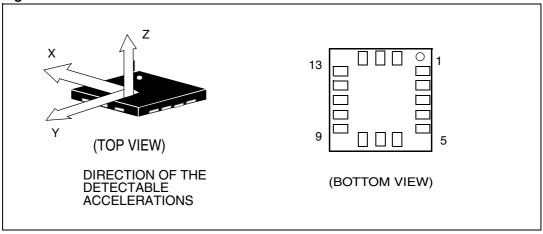


Table 1. Pin description

Pin#	Name	Function
1	Vdd_IO	Power supply for I/O pins
2	NC	Not Connected
3	NC	Not Connected
4	SCL SPC	I ² C Serial Clock (SCL) SPI Serial Port Clock (SPC)
5	GND	0V supply
6	SDA SDI SDO	I ² C Serial Data (SDA) SPI Serial Data Input (SDI) 3-wire Interface Serial Data Output (SDO)
7	SDO	SPI Serial Data Output I ² C less significant bit of the device address
8	CS	SPI enable I ² C/SPI mode selection (1: I ² C mode; 0: SPI enabled)
9	INT 2	Inertial interrupt 2
10	Reserved	Connect to Gnd
11	INT 1	Inertial interrupt 1
12	GND	0V supply
13	GND	0V supply
14	Vdd	Power supply
15	Reserved	Connect to Vdd
16	GND	0V supply

2 Mechanical and electrical specifications

2.1 Mechanical characteristics

Table 2. Mechanical characteristics (1) (2)

Symbol	Parameter	Test conditions	Min.	Typ. ⁽³⁾	Max.	Unit	
FS	Management (4)	FS bit set to 0	±2.0	±2.3			
	Measurement range ⁽⁴⁾	FS bit set to 1	±8.0	±9.2		g	
So	Sensitivity	FS bit set to 0		18		ma/digit	
30	Sensitivity	FS bit set to 1		72		mg/digit	
TCSO	Sensitivity change vs temperature	FS bit set to 0		±0.01		%/°C	
TuO#	Typical zero-g level offset	FS bit set to 0		±40		mg	
TyOff	accuracy ^{(5),(6)}	FS bit set to 1		±60		mg	
TCOff	Zero-g level change vs temperature	Max delta from 25°C		±0.5		mg/°C	
Vst	Self test output change ^{(7),(8),(9)}	FS bit set to 0 STP bit used X axis		-11		LSb	
		FS bit set to 0 STP bit used Y axis		11		LSb	
		FS bit set to 0 STP bit used Z axis		-11		LSb	
BW	System bandwidth ⁽¹⁰⁾			ODR/2		Hz	
Тор	Operating temperature range		-40		+85	°C	
Wh	Product weight			20		mgram	

- 1. All the parameters are specified @ Vdd= 2.5 V, T = 25°C unless otherwise noted
- 2. The product is factory calibrated at 2.5V. The operational power supply range is from 3.0V to 3.6V.
- 3. Typical specifications are not guaranteed
- 4. Verified by wafer level test and measurement of initial offset and sensitivity
- 5. Typical zero-g level offset value after MSL3 preconditioning
- 6. Offset can be eliminated by enabling the built-in high pass filter
- 7. If STM bit is used values change in sign for all axes
- 8. Self Test output changes with the power supply. Self test "output change" is defined as OUTPUT[LSb]_(Self-test bit on ctrl_reg1=1) -OUTPUT[LSb]_(Self-test bit on ctrl_reg1=0). 1LSb=4.6g/256 at 8bit representation, ±2.3g Full-Scale
- 9. Output data reach 99% of final value after 3/ODR when enabling Self-Test mode due to device filtering
- 10. ODR is output data rate. Refer to table 3 for specifications

2.2 Electrical characteristics

(All the parameters are specified @ Vdd=2.5V, T= 25°C unless otherwise noted)

Table 3. Electrical characteristics (1)

Symbol	Parameter	Test conditions	Min.	Typ. ⁽²⁾	Max.	Unit
Vdd	Supply voltage		2.16	2.5	3.6	V
Vdd_IO	I/O pins supply voltage ⁽³⁾		1.71		Vdd+0.1	V
ldd	Supply current	ODR=100Hz		0.3	0.4	mA
IddPdn	Current consumption in power-down mode			1	5	μА
VIH	Digital high level input voltage		0.8*Vdd _IO			V
VIL	Digital low level input voltage				0.2*Vdd _IO	V
VOH	High level output voltage		0.9*Vdd _IO			V
VOL	Low level output voltage				0.1*Vdd _IO	V
ODR	Output data rate	DR=0		100		Hz
ODR		DR=1		400		ПΖ
BW	System bandwidth ⁽⁴⁾			ODR/2		Hz
Ton	Turn-on time ⁽⁵⁾			3/ODR		s
Тор	Operating temperature range		-40		+85	°C

^{1.} The product is factory calibrated at 2.5V. The operational power supply range is from 3.0V to 3.6V.

^{2.} Typical specification are not guaranteed

^{3.} It is possible to remove Vdd maintaining Vdd_IO without blocking the communication busses, in this condition the measurement chain is powered off.

^{4.} Filter cut-off frequency

^{5.} Time to obtain valid data after exiting Power-Down mode

2.3 Communication interface characteristics

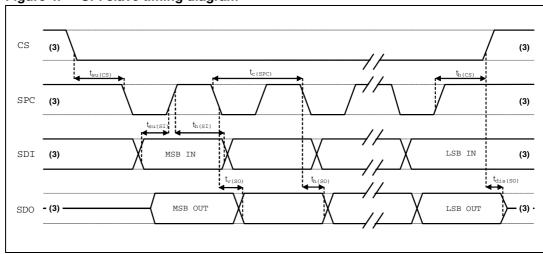
2.3.1 SPI interface

Subject to general operating conditions for Vdd and Top.

Table 4. SPI slave timing values

Symbol	Paulana atau	Value	l lmit	
	Parameter	Min	Max	Unit
tc(SPC)	SPI clock cycle	100		ns
fc(SPC)	SPI clock frequency		10	MHz
tsu(CS)	CS setup time	5		
th(CS)	CS hold time	8		
tsu(SI)	SDI input setup time	5		
th(SI)	SDI input hold time	15		ns
tv(SO)	SDO valid output time		50	
th(SO)	SDO output hold time	6		
tdis(SO)	SDO output disable time		50	





Note:

- 1 Values are guaranteed at 10MHz clock frequency for SPI with both 4 and 3 wires, based on characterization results, not tested in production
- 2 Measurement points are done at 0.2·Vdd_IO and 0.8·Vdd_IO, for both Input and output ports
- 3 When no communication is on-going, data on CS, SPC, SDI and SDO are driven by internal pull-up resistors

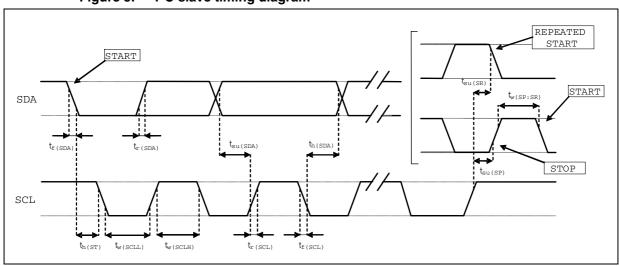
2.3.2 I²C interface

Subject to general operating conditions for Vdd and top.

Table 5. I²C Slave timing values

Cumbal	Parameter	I ² C standard mode ⁽¹⁾		I ² C fast mode ⁽¹⁾		Unit	
Symbol	Parameter	Min	Max	Min	Max		
f _(SCL)	SCL clock frequency	0	100	0	400	KHz	
t _{w(SCLL)}	SCL clock low time	4.7		1.3		ш	
t _{w(SCLH)}	SCL clock high time	4.0		0.6		μs	
t _{su(SDA)}	SDA setup time	250		100		ns	
t _{h(SDA)}	SDA data hold time	0	3.45 ⁽²⁾	0	0.9 ⁽²⁾	μs	
t _{r(SDA)} t _{r(SCL)}	SDA and SCL rise time		1000	20 + 0.1C _b ⁽³⁾	300	ns	
t _{f(SDA)} t _{f(SCL)}	SDA and SCL fall time		300	20 + 0.1C _b ⁽³⁾	300	115	
t _{h(ST)}	START condition hold time	4		0.6			
t _{su(SR)}	Repeated START condition setup time	4.7		0.6			
t _{su(SP)}	STOP condition setup time	4		0.6		μs	
t _{w(SP:SR)}	Bus free time between STOP and START condition	4.7		1.3			

Figure 5. I²C slave timing diagram ⁽⁴⁾



Note: 1 Data based on standard I²C protocol requirement, not tested in production

- 2 A device must internally provide an hold time of at least 300ns for the SDA signal (referred to V_{IHmin} of the SCL signal) to bridge the undefined region of the falling edge of SCL
- 3 Cb = total capacitance of one bus line, in pF
- 4 Measurement points are done at 0.2·Vdd_IO and 0.8·Vdd_IO, for both port

2.4 Absolute maximum ratings

Stresses above those listed as "absolute maximum ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device under these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

Table 6. Absolute maximum ratings

Symbol	Ratings	Maximum value	Unit
Vdd	Supply voltage	-0.3 to 6	V
Vdd_IO	I/O pins Supply voltage	-0.3 to 6	V
Vin	Input voltage on any control pin (CS, SCL/SPC, SDA/SDI/SDO)	-0.3 to Vdd_IO +0.3	٧
Δ.	Acceleration (any axis, powered, Vdd=2.5V)	3000g for 0.5 ms	
A _{POW}	Acceleration (any axis, powered, vdd=2.5v)	10000g for 0.1 ms	
^	Acceleration (any axis, unpowered)	3000g for 0.5 ms	
A _{UNP}	Acceleration (any axis, unpowered)	10000g for 0.1 ms	
T _{OP}	Operating temperature range	-40 to +85	°C
T _{STG}	Storage temperature range	-40 to +125	°C
ESD	Electrostatic discharge protection	0 - 2 (HBM)	kV

Note:

Supply voltage on any pin should never exceed 6.0V



This is a mechanical shock sensitive device, improper handling can cause permanent damages to the part



This is an ESD sensitive device, improper handling can cause permanent damages to the part

2.5 Terminology

2.5.1 Sensitivity

Sensitivity describes the gain of the sensor and can be determined e.g. by applying 1g acceleration to it. As the sensor can measure DC accelerations this can be done easily by pointing the axis of interest towards the center of the earth, noting the output value, rotating the sensor by 180 degrees (pointing to the sky) and noting the output value again. By doing so, $\pm 1g$ acceleration is applied to the sensor. Subtracting the larger output value from the smaller one and dividing the result by 2 leads to the actual sensitivity of the sensor. This value changes very little over temperature and also time. The Sensitivity Tolerance describes the range of Sensitivities of a large population of sensors.

2.5.2 Zero-g level

Zero-g level Offset (TyOff) describes the deviation of an actual output signal from the ideal output signal if no acceleration is present. A sensor in a steady state on a horizontal surface will measure 0g in X axis and 0g in Y axis whereas the Z axis will measure 1g. The output is ideally in the middle of the dynamic range of the sensor (content of OUT registers 00h, data expressed as 2's complement number). A deviation from ideal value in this case is called Zero-g offset. Offset is to some extent a result of stress to MEMS sensor and therefore the offset can slightly change after mounting the sensor onto a printed circuit board or exposing it to extensive mechanical stress. Offset changes little over temperature, see "Zero-g level change vs. temperature". The Zero-g level tolerance (TyOff) describes the Standard Deviation of the range of Zero-g levels of a population of sensors.

2.5.3 Self test

Self Test allows to check the sensor functionality without moving it. The Self Test function is off when the self-test bit of ctrl_reg1 (control register 1) is programmed to '0'. When the self-test bit of ctrl_reg1 is programmed to '1' an actuation force is applied to the sensor, simulating a definite input acceleration. In this case the sensor outputs will exhibit a change in their DC levels which are related to the selected full scale through the device sensitivity. When Self Test is activated, the device output level is given by the algebric sum of the signals produced by the acceleration acting on the sensor and by the electrostatic test-force. If the output signals change within the amplitude specified inside Table 2, then the sensor is working properly and the parameters of the interface chip are within the defined specifications.

2.5.4 Click and double click recognition

The click and double click recognition functions help to create man-machine interface with little software overload. The device can be configured to output an interrupt signal on dedicated pin when tapped in any direction.

If the sensor is exposed to a single input stimulus it generates an interrupt request on inertial interrupt pins (INT1 and/or INT2). A more advanced feature allows to generate an interrupt request when a "double click" stimulus is applied. A programmable time between the two events allows a flexible adaption to the application requirements. Mouse-button like application like clicks and double clicks can be implemented.

This function can be fully programmed by the user in terms of expected amplitude and timing of the stimuli.

LIS331DL Functionality

3 Functionality

The LIS331DL is a nano, low-power, digital output 3-axis linear accelerometer packaged in a LGA package. The complete device includes a sensing element and an IC interface able to take the information from the sensing element and to provide a signal to the external world through an I²C/SPI serial interface.

3.1 Sensing element

A proprietary process is used to create a surface micro-machined accelerometer. The technology allows to carry out suspended silicon structures which are attached to the substrate in a few points called anchors and are free to move in the direction of the sensed acceleration. To be compatible with the traditional packaging techniques a cap is placed on top of the sensing element to avoid blocking the moving parts during the moulding phase of the plastic encapsulation.

When an acceleration is applied to the sensor the proof mass displaces from its nominal position, causing an imbalance in the capacitive half-bridge. This imbalance is measured using charge integration in response to a voltage pulse applied to the capacitor.

At steady state the nominal value of the capacitors are few pF and when an acceleration is applied the maximum variation of the capacitive load is in fF range.

3.2 IC interface

The complete measurement chain is composed by a low-noise capacitive amplifier which converts the capacitive unbalancing of the MEMS sensor into an analog voltage that is finally available to the user by analog-to-digital converters.

The acceleration data may be accessed through an I²C/SPI interface thus making the device particularly suitable for direct interfacing with a microcontroller.

The LIS331DL features a Data-Ready signal (RDY) which indicates when a new set of measured acceleration data is available thus simplifying data synchronization in the digital system that uses the device.

The LIS331DL may also be configured to generate an inertial Wake-Up and Free-Fall interrupt signal accordingly to a programmed acceleration event along the enabled axes. Both Free-Fall and Wake-Up can be available simultaneously on two different pins.

3.3 Factory calibration

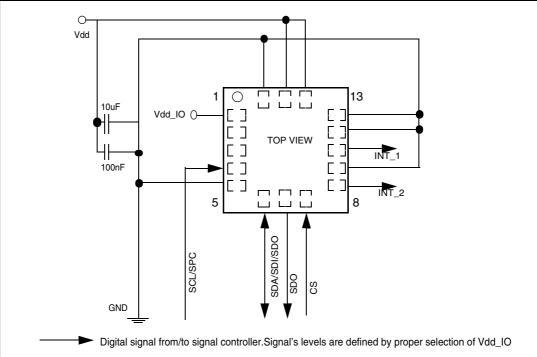
The IC interface is factory calibrated for sensitivity (So) and Zero-q level (TyOff).

The trimming values are stored inside the device in a non volatile memory. Any time the device is turned on, the trimming parameters are downloaded into the registers to be used during the normal operation. This allows to use the device without further calibration.

Application hints LIS331DL

4 Application hints

Figure 6. LIS331DL electrical connection



The device core is supplied through Vdd line while the I/O pads are supplied through Vdd_IO line. Power supply decoupling capacitors (100 nF ceramic, 10 μ F AI) should be placed as near as possible to the pin 14 of the device (common design practice).

All the voltage and ground supplies must be present at the same time to have proper behavior of the IC (refer to *Figure 3*). It is possible to remove Vdd maintaining Vdd_IO without blocking the communication bus, in this condition the measurement chain is powered off.

The functionality of the device and the measured acceleration data is selectable and accessible through the I²C/SPI interface. When using the I²C, CS must be tied high while SDO must be left floating.

The functions, the threshold and the timing of the two interrupt pins (INT 1 and INT 2) can be completely programmed by the user through the I^2C/SPI interface.

4.1 Soldering information

The LGA package is compliant with the ECOPACK®, RoHS and "green" standard. It is qualified for soldering heat resistance according to JEDEC J-STD-020C. Pin #1 indicator is electrically connected to pin 1. Leave pin 1 indicator unconnected during soldering. Land pattern and soldering recommendations are available at www.st.com.

LIS331DL Digital interfaces

5 Digital interfaces

The registers embedded inside the LIS331DL may be accessed through both the I²C and SPI serial interfaces. The latter may be SW configured to operate either in 3-wire or 4-wire interface mode.

The serial interfaces are mapped onto the same pads. To select/exploit the I²C interface, CS line must be tied high (i.e connected to Vdd_IO).

Table 7.	Serial	interface	pin o	descriptio	n

Pin name	Pin description
CS	SPI enable I ² C/SPI mode selection (1: I ² C mode; 0: SPI enabled)
SCL/SPC	I ² C Serial Clock (SCL) SPI Serial Port Clock (SPC)
SDA/SDI/SDO	I ² C Serial Data (SDA) SPI Serial Data Input (SDI) 3-wire Interface Serial Data Output (SDO)
SDO	SPI Serial Data Output (SDO)

5.1 I²C serial interface

The LIS331DL I²C is a bus slave. The I²C is employed to write data into registers whose content can also be read back.

The relevant I²C terminology is given in the table below.

Table 8. Serial interface pin description

Term	Description
Transmitter	The device which sends data to the bus
Receiver	The device which receives data from the bus
Master	The device which initiates a transfer, generates clock signals and terminates a transfer
Slave	The device addressed by the master

There are two signals associated with the I²C bus: the Serial Clock Line (SCL) and the Serial DAta line (SDA). The latter is a bidirectional line used for sending and receiving the data to/from the interface. Both the lines are connected to Vdd_IO through a pull-up resistor embedded inside the LIS331DL. When the bus is free both the lines are high.

The I^2C interface is compliant with fast mode (400 kHz) I^2C standards as well as with the normal mode.

Digital interfaces LIS331DL

5.1.1 I²C operation

The transaction on the bus is started through a START (ST) signal. A START condition is defined as a HIGH to LOW transition on the data line while the SCL line is held HIGH. After this has been transmitted by the Master, the bus is considered busy. The next byte of data transmitted after the start condition contains the address of the slave in the first 7 bits and the eighth bit tells whether the Master is receiving data from the slave or transmitting data to the slave. When an address is sent, each device in the system compares the first seven bits after a start condition with its address. If they match, the device considers itself addressed by the Master.

The Slave ADdress (SAD) associated to the LIS331DL is 001110xb. **SDO** pad can be used to modify less significant bit of the device address. If SDO pad is connected to voltage supply LSb is '1' (address 0011101b) else if SDO pad is connected to ground LSb value is '0' (address 0011100b). This solution permits to connect and address two different accelerometer to the same I²C lines.

Data transfer with acknowledge is mandatory. The transmitter must release the SDA line during the acknowledge pulse. The receiver must then pull the data line LOW so that it remains stable low during the HIGH period of the acknowledge clock pulse. A receiver which has been addressed is obliged to generate an acknowledge after each byte of data has been received.

The I²C embedded inside the LIS331DL behaves like a slave device and the following protocol must be adhered to. After the start condition (ST) a slave address is sent, once a slave acknowledge (SAK) has been returned, a 8-bit sub-address will be transmitted: the 7 LSb represent the actual register address while the MSB enables address auto increment. If the MSb of the SUB field is 1, the SUB (register address) will be automatically incremented to allow multiple data read/write.

The slave address is completed with a Read/Write bit. If the bit was '1' (Read), a repeated START (SR) condition will have to be issued after the two sub-address bytes; if the bit is '0' (Write) the Master will transmit to the slave with direction unchanged.

Transfer when master is writing one byte to slave

Master	ST	SAD + W		SUB		DATA		SP
Slave			SAK		SAK		SAK	

Transfer when master is writing multiple bytes to slave:

Master	ST	SAD + W		SUB		DATA		DATA		SP
Slave			SAK		SAK		SAK		SAK	

Transfer when master is receiving (reading) one byte of data from slave:

	Master	ST	SAD + W		SUB		SR	SAD + R			NMAK	SP
Ī	Slave			SAK		SAK			SAK	DATA		

LIS331DL Digital interfaces

Transfer when master is receiving (reading) multiple bytes of data from slave:

Master	ST	SAD + W		SUB		SR	SAD + R			MAK
Slave			SAK		SAK			SAK	DATA	

Master		MAK		NMAK	SP
Slave	DATA		DATA		

Data are transmitted in byte format (DATA). Each data transfer contains 8 bits. The number of bytes transferred per transfer is unlimited. Data is transferred with the Most Significant bit (MSb) first. If a receiver can't receive another complete byte of data until it has performed some other function, it can hold the clock line, SCL LOW to force the transmitter into a wait state. Data transfer only continues when the receiver is ready for another byte and releases the data line. If a slave receiver doesn't acknowledge the slave address (i.e. it is not able to receive because it is performing some real time function) the data line must be left HIGH by the slave. The Master can then abort the transfer. A LOW to HIGH transition on the SDA line while the SCL line is HIGH is defined as a STOP condition. Each data transfer must be terminated by the generation of a STOP (SP) condition.

In order to read multiple bytes, it is necessary to assert the most significant bit of the sub-address field. In other words, SUB(7) must be equal to 1 while SUB(6-0) represents the address of first register to be read.

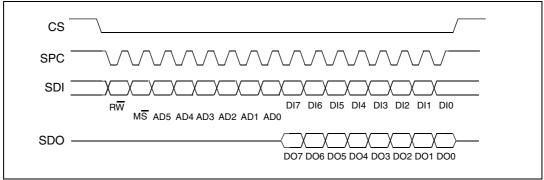
In the presented communication format MAK is Master Acknowledge and NMAK is No Master Acknowledge.

5.2 SPI bus interface

The LIS331DL SPI is a bus slave. The SPI allows to write and read the registers of the device.

The Serial Interface interacts with the outside world with 4 wires: CS, SPC, SDI and SDO.

Figure 7. Read & write protocol



CS is the Serial Port Enable and it is controlled by the SPI master. It goes low at the start of the transmission and goes back high at the end. **SPC** is the Serial Port Clock and it is controlled by the SPI master. It is stopped high when **CS** is high (no transmission). **SDI** and

Digital interfaces LIS331DL

SDO are respectively the Serial Port Data Input and Output. Those lines are driven at the falling edge of **SPC** and should be captured at the rising edge of **SPC**.

Both the Read Register and Write Register commands are completed in 16 clock pulses or in multiple of 8 in case of multiple bytes read/write. Bit duration is the time between two falling edges of **SPC**. The first bit (bit 0) starts at the first falling edge of **SPC** after the falling edge of **CS** while the last bit (bit 15, bit 23, ...) starts at the last falling edge of SPC just before the rising edge of **CS**.

bit 0: \overline{RW} bit. When 0, the data DI(7:0) is written into the device. When 1, the data DO(7:0) from the device is read. In latter case, the chip will drive **SDO** at the start of bit 8.

bit 1: MS bit. When 0, the address will remain unchanged in multiple read/write commands. When 1, the address will be auto incremented in multiple read/write commands.

bit 2-7: address AD(5:0). This is the address field of the indexed register.

bit 8-15: data DI(7:0) (write mode). This is the data that will be written into the device (MSb first).

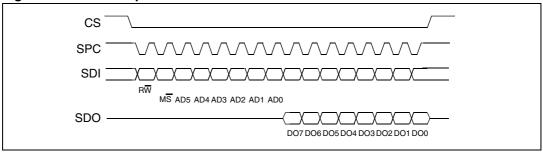
bit 8-15: data DO(7:0) (read mode). This is the data that will be read from the device (MSb first).

In multiple read/write commands further blocks of 8 clock periods will be added. When \overline{MS} bit is 0 the address used to read/write data remains the same for every block. When \overline{MS} bit is 1 the address used to read/write data is incremented at every block.

The function and the behavior of SDI and SDO remain unchanged.

5.2.1 SPI read

Figure 8. SPI read protocol



The SPI Read command is performed with 16 clock pulses. Multiple byte read command is performed adding blocks of 8 clock pulses at the previous one.

bit 0: READ bit. The value is 1.

bit 1: MS bit. When 0 do not increment address, when 1 increment address in multiple reading.

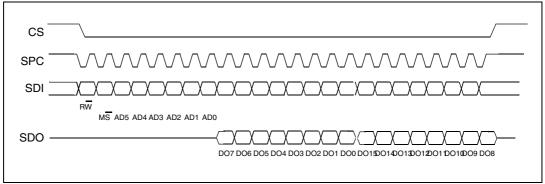
bit 2-7: address AD(5:0). This is the address field of the indexed register.

bit 8-15: data DO(7:0) (read mode). This is the data that will be read from the device (MSb first).

bit 16-...: data DO(...-8). Further data in multiple byte reading.

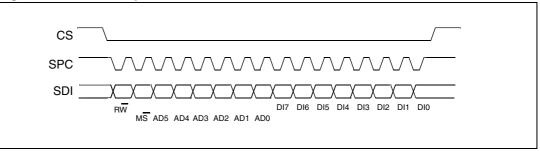
LIS331DL Digital interfaces

Figure 9. Multiple bytes SPI read protocol (2 bytes example)



5.2.2 SPI write

Figure 10. SPI write protocol



The SPI Write command is performed with 16 clock pulses. Multiple byte write command is performed adding blocks of 8 clock pulses at the previous one.

bit 0: WRITE bit. The value is 0.

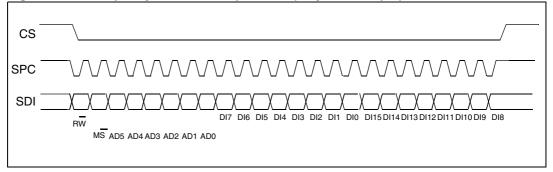
bit 1: MS bit. When 0 do not increment address, when 1 increment address in multiple writing.

bit 2 -7: address AD(5:0). This is the address field of the indexed register.

bit 8-15: data DI(7:0) (write mode). This is the data that will be written inside the device (MSb first).

bit 16-...: data DI(...-8). Further data in multiple byte writing.

Figure 11. Multiple bytes SPI write protocol (2 bytes example)

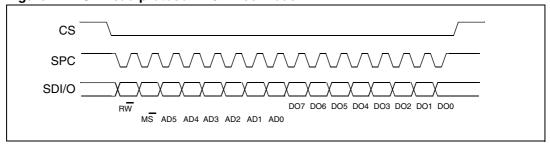


Digital interfaces LIS331DL

5.2.3 SPI read in 3-wires mode

3-wires mode is entered by setting to 1 bit SIM (SPI Serial Interface Mode selection) in CTRL REG2.

Figure 12. SPI read protocol in 3-wires mode



The SPI Read command is performed with 16 clock pulses:

bit 0: READ bit. The value is 1.

bit 1: MS bit. When 0 do not increment address, when 1 increment address in multiple reading.

bit 2-7: address AD(5:0). This is the address field of the indexed register.

bit 8-15: data DO(7:0) (read mode). This is the data that will be read from the device (MSb first).

Multiple read command is also available in 3-wires mode.

LIS331DL Register mapping

6 Register mapping

The table given below provides a listing of the 8 bit registers embedded in the device and the related address:

Table 9. Register address map

Nome	Turne	Registe	r address	Defect	Commont
Name	Туре	Hex	Binary	Default	Comment
Reserved (do not modify)		00-0E			Reserved
Who_am_i	r	0F	000 1111	00111011	Dummy register
Reserved (do not modify)		10-1F			Reserved
Ctrl_Reg1	rw	20	010 0000	00000111	
Ctrl_Reg2	rw	21	010 0001	00000000	
Ctrl_Reg3	rw	22	010 0010	00000000	
HP_filter_reset	r	23	010 0011	dummy	Dummy register
Reserved (do not modify)		24-26			Reserved
Status_Reg	r	27	010 0111	00000000	
	r	28	010 1000		Not Used
OutX	r	29	010 1001	output	
	r	2A	010 1010		Not Used
OutY	r	2B	010 1011	output	
	r	2C	010 1100		Not Used
OutZ	r	2D	010 1101	output	
Reserved (do not modify)		2E-2F			Reserved
FF_WU_CFG_1	rw	30	011 0000	00000000	
FF_WU_SRC_1(ack1)	r	31	011 0001	00000000	
FF_WU_THS_1	rw	32	011 0010	00000000	
FF_WU_DURATION_1	rw	33	011 0011	00000000	
FF_WU_CFG_2	rw	34	011 0100	00000000	
FF_WU_SRC_2 (ack2)	r	35	011 0101	00000000	
FF_WU_THS_2	rw	36	011 0110	00000000	
FF_WU_DURATION_2	rw	37	011 0111	00000000	
CLICK_CFG	rw	38	011 1000	00000000	
CLICK_SRC (ack)	r	39	011 1001	00000000	
		3A			Not Used
CLICK_THSY_X	rw	3B	011 1011	00000000	

Register mapping LIS331DL

Table 9. Register address map

Name	Type	Register address			Comment
Name	Туре	Hex	Binary	- Default	Comment
CLICK_THSZ	rw	3C	011 1100	00000000	
CLICK_TimeLimit	rw	3D	011 1101	00000000	
CLICK_Latency	rw	3E	011 1110	00000000	
CLICK_Window	rw	3F	011 1111	00000000	

Registers marked as reserved must not be changed. The writing to those registers may cause permanent damages to the device.

The content of the registers that are loaded at boot should not be changed. They contain the factory calibration values. Their content is automatically restored when the device is powered-up.

7 Register description

The device contains a set of registers which are used to control its behavior and to retrieve acceleration data. The registers address, made of 7 bits, is used to identify them and to write the data through serial interface.

7.1 WHO_AM_I (0Fh)

Table 10. WHO_AM_I register

0	0	1	1	1	0	1	1
---	---	---	---	---	---	---	---

Device identification register.

This register contains the device identifier that for LIS302DL is set to 3Bh.

7.2 CTRL_REG1 (20h)

Table 11. CTRL_REG1 register

	PD FS	STP	STM	Zen	Yen	Xen
--	-------	-----	-----	-----	-----	-----

Table 12. CTRL_REG1 description

DR	Data rate selection. Default value: 0 (0: 100 Hz output data rate; 1: 400 Hz output data rate)
PD	Power Down Control. Default value: 0 (0: power down mode; 1: active mode)
FS	Full Scale selection. Default value: 0 (refer to table 2 for typical full scale value)
STP, STM	Self Test Enable. Default value: 0 (0: normal mode; 1: self test P, M enabled)
Zen	Z axis enable. Default value: 1 (0: Z axis disabled; 1: Z axis enabled)
Yen	Y axis enable. Default value: 1 (0: Y axis disabled; 1: Y axis enabled)
Xen	X axis enable. Default value: 1 (0: X axis disabled; 1: X axis enabled)

DR bit allows to select the data rate at which acceleration samples are produced. The default value is 0 which corresponds to a data-rate of 100Hz. By changing the content of DR to "1" the selected data-rate will be set equal to 400Hz.

PD bit allows to turn on the turn the device out of power-down mode. The device is in power-down mode when PD= "0" (default value after boot). The device is in normal mode when PD is set to 1.

Register description LIS331DL

STP, STM bits are used to activate the self test function. When the bit is set to one, an output change will occur to the device outputs (refer to table 2 and 3 for specification) thus allowing to check the functionality of the whole measurement chain.

Zen bit enables the generation of Data Ready signal for Z-axis measurement channel when set to 1. The default value is 1.

Yen bit enables the generation of Data Ready signal for Y-axis measurement channel when set to 1. The default value is 1.

Xen bit enables the generation of Data Ready signal for X-axis measurement channel when set to 1. The default value is 1.

7.3 CTRL_REG2 (21h)

Table 13. CTRL_REG2 register

SIM	воот	0 ⁽¹⁾	FDS	HP FF_WU2	HP FF_WU1	HP_coeff2	HP_coeff1
				FF_VVU2	FF_WUI		

^{1.} Bit to be kept to "0" for correct device functionality

Table 14. CTRL_REG2 description

	-
SIM	SPI Serial Interface Mode selection. Default value: 0 (0: 4-wire interface; 1: 3-wire interface)
воот	Reboot memory content. Default value: 0 (0: normal mode; 1: reboot memory content)
FDS	Filtered Data Selection. Default value: 0 (0: internal filter bypassed; 1: data from internal filter sent to output register)
HP FF_WU2	High Pass filter enabled for Free-Fall/WakeUp # 2. Default value: 0 (0: filter bypassed; 1: filter enabled)
HP FF_WU1	High Pass filter enabled for Free-Fall/Wake-Up #1. Default value: 0 (0: filter bypassed; 1: filter enabled)
HP coeff2 HP coeff1	High pass filter cut-off frequency configuration. Default value: 00 (See table below

SIM bit selects the SPI Serial Interface Mode. When SIM is '0' (default value) the 4-wire interface mode is selected. The data coming from the device are sent to SDO pad. In 3-wire interface mode output data are sent to SDA_SDI pad.

BOOT bit is used to refresh the content of internal registers stored in the flash memory block. At the device power up the content of the flash memory block is transferred to the internal registers related to trimming functions to permit a good behavior of the device itself. If for any reason the content of trimming registers was changed it is sufficient to use this bit to restore correct values. When BOOT bit is set to '1' the content of internal flash is copied inside corresponding internal registers and it is used to calibrate the device. These values are factory trimmed and they are different for every accelerometer. They permit a good behavior of the device and normally they have not to be changed. At the end of the boot process the BOOT bit is set again to '0'.

FDS bit enables (FDS=1) or bypass (FDS=0) the high pass filter in the signal chain of the sensor

HP_coeff[2:1]. These bits are used to configure high-pass filter cut-off frequency ft.

Table 15. High pass filter cut-off frequency configuration

HPcoeff2,1	ft (Hz) (ODR=100 Hz)	ft (Hz) (ODR=400 Hz)
00	2	8
01	1	4
10	0.5	2
11	0.25	1

7.4 CTRL_REG3 [interrupt CTRL register] (22h)

Table 16. CTRL_REG3 register

IHL	PP_OD	I2CFG2	I2CFG1	I2CFG0	I1CFG2	I1CFG1	I1CFG0

Table 17. CTRL_REG3 description

	- •
IHL	Interrupt active high, low. Default value 0. (0: active high; 1: active low)
PP_OD	Push-pull/Open Drain selection on interrupt pad. Default value 0. (0: push-pull; 1: open drain)
I2CFG2 I2CFG1 I2CFG0	Data Signal on Int2 pad control bits. Default value 000. (see table below)
I1CFG2 I1CFG1 I1CFG0	Data Signal on Int1 pad control bits. Default value 000. (see table below)

Table 18. Data Signal on Int1 pad control bits

	ngnar on mit paa t		_	
I1(2)_CFG2	I1(2)_CFG1	I1(2)_CFG0	Int1(2) Pad	
0	0	0	GND	
0	0	1	FF_WU_1	
0	1	0	FF_WU_2	
0	1	1	FF_WU_1 or FF_WU_2	
1	0	0	Data ready	
1	1	1	Click interrupt	

7.5 HP_FILTER_RESET (23h)

Dummy register. Reading at this address zeroes instantaneously the content of the internal high pass-filter. If the high pass filter is enabled all three axes are instantaneously set to 0g. This allows to overcome the settling time of the high pass filter.

Register description LIS331DL

7.6 **STATUS_REG** (27h)

Table 19. STATUS_REG register

ZATOIT ZOTT TOTT AOTT ZTADAT ZDAT TDAT ADAT	ZXYOR	ZOR	YOR	XOR	ZYXDA	ZDA	YDA	XDA
---	-------	-----	-----	-----	-------	-----	-----	-----

Table 20. STATUS_REG description

	 '
ZYXOR	X, Y and Z axis Data Overrun. Default value: 0 (0: no overrun has occurred; 1: new data has overwritten the previous one before it was read)
ZOR	Z axis Data Overrun. Default value: 0 (0: no overrun has occurred; 1: a new data for the Z-axis has overwritten the previous one)
YOR	Y axis Data Overrun. Default value: 0 (0: no overrun has occurred; 1: a new data for the Y-axis has overwritten the previous one)
XOR	X axis Data Overrun. Default value: 0 (0: no overrun has occurred; 1: a new data for the X-axis has overwritten the previous one)
ZYXDA	X, Y and Z axis new Data Available. Default value: 0 (0: a new set of data is not yet available; 1: a new set of data is available)
ZDA	Z axis new Data Available. Default value: 0 (0: a new data for the Z-axis is not yet available; 1: a new data for the Z-axis is available)
YDA	Y axis new Data Available. Default value: 0 (0: a new data for the Y-axis is not yet available; 1: a new data for the Y-axis is available)
XDA	X axis new Data Available. Default value: 0 (0: a new data for the X-axis is not yet available; 1: a new data for the X-axis is available)

7.7 OUT_X (29h)

Table 21. OUT_X register

XD7 XD6 XD5	XD4 XD3	XD2 XD1	XD0
-------------	---------	---------	-----

X axis output data.

7.8 OUT_Y (2Bh)

Table 22. OUT_Y register

YD7	YD7	YD6	YD5	YD4	YD3	YD2	YD1	YD0
-----	-----	-----	-----	-----	-----	-----	-----	-----

Y axis output data.

7.9 OUT_Z (2Dh)

Table 23. OUT_Z register

ZD7 ZD6 ZD5	ZD4	ZD3	ZD2	ZD1	ZD0
-------------	-----	-----	-----	-----	-----

Z axis output data.

7.10 FF_WU_CFG_1 (30h)

Table 24. FF_WU_CFG_1 register

AOI	LIR	ZHIE	ZLIE	YHIE	YLIE	XHIE	XLIE

Table 25. FF_WU_CFG_1 description

AOI	And/Or combination of Interrupt events. Default value: 0 (0: OR combination of interrupt events; 1: AND combination of interrupt events)
LIR	Latch Interrupt request into FF_WU_SRC_1 reg with the FF_WU_SRC_1 reg cleared by reading FF_WU_SRC_1 reg. Default value: 0 (0: interrupt request not latched; 1: interrupt request latched)
ZHIE	Enable interrupt generation on Z high event. Default value: 0 (0: disable interrupt request; 1: enable interrupt request on measured accel. value higher than preset threshold)
ZLIE	Enable interrupt generation on Z low event. Default value: 0 (0: disable interrupt request; 1: enable interrupt request on measured accel. value lower than preset threshold)
YHIE	Enable interrupt generation on Y high event. Default value: 0 (0: disable interrupt request; 1: enable interrupt request on measured accel. value higher than preset threshold)
YLIE	Enable interrupt generation on Y low event. Default value: 0 (0: disable interrupt request; 1: enable interrupt request on measured accel. value lower than preset threshold)
XHIE	Enable interrupt generation on X high event. Default value: 0 (0: disable interrupt request; 1: enable interrupt request on measured accel. value higher than preset threshold)
XLIE	Enable interrupt generation on X low event. Default value: 0 (0: disable interrupt request; 1: enable interrupt request on measured accel. value lower than preset threshold)

Register description LIS331DL

7.11 FF_WU_SRC_1 (31h)

Table 26. FF_WU_SRC_1 register

	IA	ZH	ZL	ΥH	YL	XH	XL

Table 27. FF_WU_SRC_1 description

IA	Interrupt Active. Default value: 0 (0: no interrupt has been generated; 1: one or more interrupts have been generated)
ZH	Z High. Default value: 0 (0: no interrupt, 1: ZH event has occurred)
ZL	Z Low. Default value: 0 (0: no interrupt; 1: ZL event has occurred)
YH	Y High. Default value: 0 (0: no interrupt, 1: YH event has occurred)
YL	Y Low. Default value: 0 (0: no interrupt, 1: YL event has occurred)
XH	X High. Default value: 0 (0: no interrupt, 1: XH event has occurred)
XL	X Low. Default value: 0 (0: no interrupt, 1: XL event has occurred)

Free-fall and wake-up source register. Read only register.

Reading at this address clears FF_WU_SRC_1 register and the FF, WU 1 interrupt and allows the refreshment of data in the FF_WU_SRC_1 register if the latched option was chosen.

7.12 FF_WU_THS_1 (32h)

Table 28. FF_WU_THS_1 register

DCRM THS6 THS5 THS4 THS3 THS2 TH	THS1 THS0
----------------------------------	-----------

Table 29. FF_WU_THS_1 description

I DC:RM I		Resetting mode selection. Default value: 0 (0: counter reset; 1: counter decremented)
	THS6, THS0	Free-fall / wake-up Threshold: default value: 000 0000

Most significant bit (DCRM) is used to select the resetting mode of the duration counter. If DCRM=0 counter is reset when the interrupt is no more active else if DCRM=1 duration counter is decremented.

LIS331DL Register description

7.13 FF_WU_DURATION_1 (33h)

Table 30. FF_WU_DURATION_1 register

D7 D6 D5 D4 D3 D2 D1 D0

Table 31. FF_WU_DURATION_1 description

D7-D0	Duration value. Default value: 0000 0000
-------	--

Duration register for Free-Fall/Wake-Up interrupt 1. Duration step and maximum value depend on the ODR chosen. Step 2.5 msec, from 0 to 637.5 msec if ODR=400Hz, else step 10 msec, from 0 to 2.55 sec when ODR=100Hz. The counter used to implement duration function is blocked when LIR=1 in configuration register and the interrupt event is verified

7.14 FF_WU_CFG_2 (34h)

Table 32. FF_WU_CFG_2 register

Table 33. FF_WU_CFG_2 description

	<u>.</u>
AOI	And/Or combination of Interrupt events. Default value: 0 (0: OR combination of interrupt events; 1: AND combination of interrupt events)
LIR	Latch Interrupt request into FF_WU_SRC_2 reg with the FF_WU_SRC_2 reg cleared by reading FF_WU_SRC_2 reg. Default value: 0 (0: interrupt request not latched; 1: interrupt request latched)
ZHIE	Enable interrupt generation on Z high event. Default value: 0 (0: disable interrupt request; 1: enable interrupt request on measured accel. value higher than preset threshold)
ZLIE	Enable interrupt generation on Z low event. Default value: 0 (0: disable interrupt request; 1: enable interrupt request on measured accel. value lower than preset threshold)
YHIE	Enable interrupt generation on Y high event. Default value: 0 (0: disable interrupt request; 1: enable interrupt request on measured accel. value higher than preset threshold)
YLIE	Enable interrupt generation on Y low event. Default value: 0 (0: disable interrupt request; 1: enable interrupt request on measured accel. value lower than preset threshold)
XHIE	Enable interrupt generation on X high event. Default value: 0 (0: disable interrupt request; 1: enable interrupt request on measured accel. value higher than preset threshold)
XLIE	Enable interrupt generation on X low event. Default value: 0 (0: disable interrupt request; 1: enable interrupt request on measured accel. value lower than preset threshold)

Register description LIS331DL

7.15 FF_WU_SRC_2 (35h)

Table 34. FF_WU_SRC_2 register

	IA	ZH	ZL	YH	YL	XH	XL

Table 35. FF_WU_SRC_2 descrption

	11_110_0110_2 dood.piloli	
IA	Interrupt Active. Default value: 0 (0: no interrupt has been generated; 1: one or more interrupt events have been generated)	
ZH	Z High. Default value: 0 (0: no interrupt; 1: ZH event has occurred)	
ZL	Z Low. Default value: 0 (0: no interrupt; 1: ZL event has occurred)	
YH	Y High. Default value: 0 (0: no interrupt; 1: YH event has occurred)	
YL	Y Low. Default value: 0 (0: no interrupt; 1: YL event has occurred)	
XH	X High. Default value: 0 (0: no interrupt; 1: XH event has occurred)	
XL	X Low. Default value: 0 (0: no interrupt; 1: XL event has occurred)	

Free-fall and wake-up source register. Read only register.

Reading at this address clears FF_WU_SRC_2 register and the FF_WU_2 interrupt and allows the refreshment of data in the FF_WU_SRC_2 register if the latched option was chosen.

7.16 FF_WU_THS_2 (36h)

Table 36. FF_WU_THS_2 register

DCRM THS6 THS5	THS4	THS3	THS2	THS1	THS0
----------------	------	------	------	------	------

Table 37. FF_WU_THS_2 description

	DCRM	Resetting mode selection. Default value: 0 (0: counter reset; 1: counter decremented)
THS6, THS0 Free-fall / wake-up Threshold. Default value: 000 000		Free-fall / wake-up Threshold. Default value: 000 0000

Most significant bit (DCRM) is used to select the resetting mode of the duration counter. If DCRM=0 counter is reset when the interrupt is no more active else if DCRM=1 duration counter is decremented.

7.17 **FF_WU_DURATION_2** (37h)

Table 38. FF_WU_DURATION_2 register

D7 D6 D5 D4 D3 D2 D1 D0

Table 39. FF_WU_DURATION_2 description

D7-D0 Duration value. Default value: 0000 0000	
--	--

Duration register for Free-Fall/Wake-Up interrupt 2. Duration step and maximum value depend on the ODR chosen. Step 2.5 msec, from 0 to 637.5 msec if ODR=400Hz, else step 10 msec, from 0 to 2.55 sec when ODR=100Hz. The counter used to implement duration function is blocked when LIR=1 in configuration register and the interrupt event is verified.

7.18 CLICK_CFG (38h)

Table 40. CLICK_CFG register

- LIR Double_Z Single_Z Double_Y Single_Y Do	ole_X Single_X
--	----------------

Table 41. CLICK_CFG description

LIR	Latch Interrupt request into CLICK_SRC reg with the CLICK_SRC reg refreshed by reading CLICK_SRC reg. Default value: 0 (0: interrupt request not latched; 1: interrupt request latched)			
Double_Z	Enable interrupt generation on double click event on Z axis. Default value: 0 (0: disable interrupt request; 1: enable interrupt request)			
Single_Z	Enable interrupt generation on single click event on Z axis. Default value: 0 (0: disable interrupt request; 1: enable interrupt request)			
Double_Y	Enable interrupt generation on double click event on Y axis. Default value: 0 (0: disable interrupt request; 1: enable interrupt request)			
Single_Y	Enable interrupt generation on single click event on Y axis. Default value: 0 (0: disable interrupt request; 1: enable interrupt request)			
Double_X	Enable interrupt generation on double click event on X axis. Default value: 0 (0: disable interrupt request; 1: enable interrupt request)			
Single_X	Enable interrupt generation on single click event on X axis. Default value: 0 (0: disable interrupt request; 1: enable interrupt request)			

Table 42. Axis

Double_Z / Y / X	Single_Z/Y/X	Click output		
0	0	0		
0	1	Single		

Register description LIS331DL

Table 42. Axis

Double_Z / Y / X	Single_Z/Y/X	Click output		
1	0	Double		
1	1	Single or double		

7.19 CLICK_SRC (39h)

Table 43. CLICK_SRC register

	IA	Double_Z	Single_Z	Double_Y	Single_Y	Double_X	Single_X
--	----	----------	----------	----------	----------	----------	----------

Table 44. CLICK_SRC description

IA	Interrupt Active. Default value: 0 (0: no interrupt has been generated; 1: one or more interrupt events have been generated)
Double_Z	Double click on Z axis event. Default value: 0 (0: no interrupt; 1: Double Z event has occurred)
Single_Z	Single click on Z axis event. Default value: 0 (0: no interrupt; 1: Single Z event has occurred)
Double_Y	Double click on Y axis event. Default value: 0 (0: no interrupt; 1: Double Y event has occurred)
Single_Y	Single click on Y axis event.Default value: 0 (0: no interrupt; 1: Single Y event has occurred)
Double_X	Double click on X axis event. Default value: 0 (0: no interrupt; 1: Double X event has occurred)
Single_X	Single click on X axis event. Default value: 0 (0: no interrupt; 1: Single X event has occurred)

7.20 CLICK_THSY_X (3Bh)

Table 45. CLICK_THSY_X register

THSy3	THSy2	THSy1	THSy0	THSx3	THSx2	THSx1	THSx0

Table 46. CLICK_THSY_X description

THSy3, THSy0	Click Threshold on Y axis. Default value: 0000
THSx3, THSx0	Click Threshold on X axis. Default value: 0000

From 0.5g(0001) to 7.5g(1111) with step of 0.5g.

7.21 CLICK_THSZ (3Ch)

Table 47. CLICK_THSZ register

THSz3 THSz2 THSz1 THSz

Table 48. CLICK_THSZ description

THSz3, THSz0 Click Threshold on Z axis. Default value: 0000

From 0.5g(0001) to 7.5g(1111) with step of 0.5g.

7.22 CLICK_TimeLimit (3Dh)

Table 49. CLICK_TimeLimit register

Dur7 Dur6 Dur5 Dur4 Dur3 Dur2 Dur1 D	Dur7	Dur6 Dur5	Dur5 Dur4	Dur3	Dur2	Dur1	Dur0
--	------	-----------	-----------	------	------	------	------

From 0 to 127.5msec with step of 0.5 msec,

7.23 CLICK_Latency (3Eh)

Table 50. CLICK_Latency

Lat7	Lat6	Lat5	Lat4	Lat3	Lat2	Lat1	Lat0

From 0 to 255 msec with step of 1 msec.

7.24 CLICK_Window (3Fh)

Table 51. CLICK_Window register

Win7 Win6 Win5 Win4 Win3 Win2 Win1 Win0

From 0 to 255 msec with step of 1 msec.

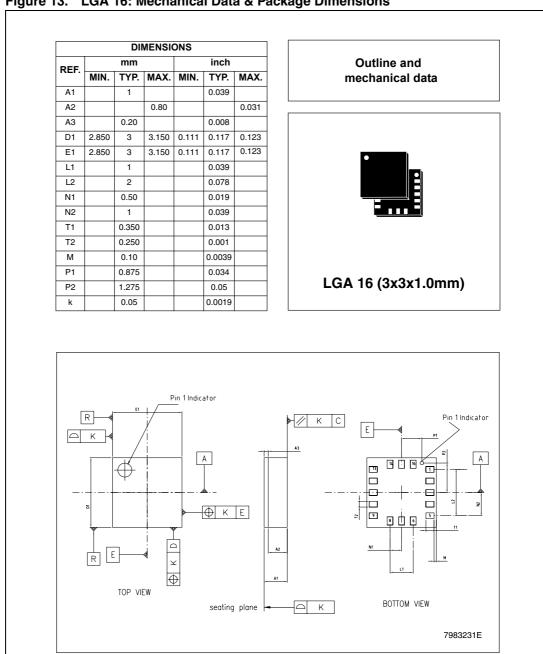
Package information LIS331DL

Package information 8

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second Level Interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK® is an ST trademark.

ECOPACK® specifications are available at: www.st.com.

Figure 13. LGA 16: Mechanical Data & Package Dimensions



LIS331DL Revision history

9 Revision history

Table 52. Document revision history

Date	Revision	Changes
28-Sep-2007	1	Initial release

Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY AN AUTHORIZED ST REPRESENTATIVE, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2007 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com